# Suppressed Blinking Dynamics of Single QDs on ITO

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ARTICLE

he fluorescence and interfacial charge transfer properties of colloidal semiconductor quantum dots (QD) are essential for their many applications, such as light-emitting diodes<sup>1,2</sup> and solar cells.<sup>3–5</sup> Single QDs on inert substrates exhibit strong intermittence in fluorescence intensity (known as "blinking").6-33 The blinking activity is attributed to the photoinduced charging of QDs by electron transfer (ET) to trap states in QDs and the surrounding matrix and has been considered as an undesirable property in many applications. There have been many efforts to design novel QD structures and schemes for suppressing the blinking activity.<sup>26-34</sup> More recently, how the blinking dynamics affect the ET activity of single QDs has also been investigated.<sup>35–37</sup> The blinking activity was found to lead to intermittent ET dynamics for single QDs on TiO<sub>2</sub><sup>36</sup> and adsorbed with electron acceptors.35,37 It remains unclear how the fluorescence property of single QDs is affected under device environment, in which QDs may be charged and interfacial charge transfer processes are active. For example, a recent ensemble average measurement has shown that, under external bias, QDs can be charged and their exciton lifetimes can be greatly reduced.<sup>38</sup> An important component of many QD-based devices is the interface between QDs and the conducting transparent electrodes, such as tin-doped indium oxide (ITO). Because the conduction band edge of ITO is lower than that of QDs, photoinduced interfacial ET from QDs to ITO is energetically allowed. Furthermore, as an n-doped semiconductor, the Fermi level in ITO is near its conduction band edge and higher than that of a neutral QD. When these materials are in contact, the equilibration of their Fermi lev-

**ABSTRACT** The exciton quenching dynamics of single CdSe/CdS<sub>3ML</sub>ZnCdS<sub>2ML</sub>ZnS<sub>2ML</sub> core/multishell QDs adsorbed on glass, In<sub>2</sub>O<sub>3</sub>, and ITO have been compared. Single QDs on In<sub>2</sub>O<sub>3</sub> show shorter fluorescence lifetimes and higher blinking frequencies than those on glass because of interfacial electron transfer from QDs to In<sub>2</sub>O<sub>3</sub>. Compared to glass and In<sub>2</sub>O<sub>3</sub>, single QDs on ITO show suppressed blinking activity as well as reduced fluorescence lifetimes. For QDs in contact with the n-doped ITO, the equilibration of their Fermi levels leads to the formation of negatively charged QDs. In these negatively charged QDs, the off states are suppressed because of the effective removal of the valence band holes, and their fluorescence lifetimes are shortened because of exciton Auger recombination and hole transfer processes involving the additional electrons. This study shows that the blinking of single QDs can be effectively suppressed on the surface of ITO. This phenomenon may also be observable for other QDs and on different n-doped semiconductors.

**KEYWORDS:** CdSe/CdS<sub>3ML</sub>ZnCdS<sub>2ML</sub>ZnS<sub>2ML</sub> core/multishell QDs · single QD · charged QDs · suppressed blinking dynamics · interfacial electron transfer · Auger relaxation

els leads to the formation of negatively charged QDs. Both the formation of charged particles and the presence of interfacial electron transfer pathways will likely affect the fluorescence lifetime and blinking activity of the QDs. To investigate these effects, we have studied exciton guenching dynamics of single QDs adsorbed on an ITOcoated coverslip and compared them with those on glass and In<sub>2</sub>O<sub>3</sub> nanocrystalline thin films. We report here that, for single QDs on ITO, their exciton lifetimes are significantly shortened and their blinking activities are dramatically suppressed. We discuss the possible origins of the observed phenomenon.

# **RESULTS AND DISCUSSION**

The fluorescence intensity and lifetime trajectories were recorded for 47, 45, and 50 single CdSe/(CdS)<sub>3ML</sub>(ZnCdS)<sub>2ML</sub>(ZnS)<sub>2ML</sub> core/multishell QDs on ITO, glass, and In<sub>2</sub>O<sub>3</sub>, respectively. Figure 1 shows typical fluorescence intensity and lifetime trajectories of

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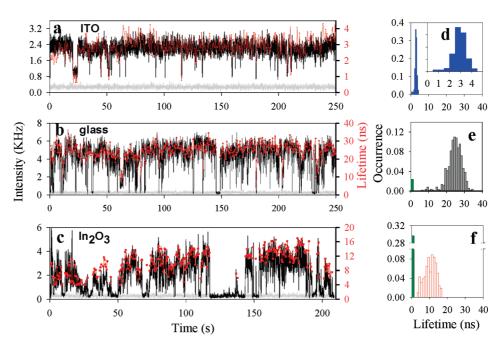


Figure 1. Typical fluorescence intensity (black) and lifetime (red) trajectories of single QDs on (a) ITO, (b) glass, and (c)  $In_2O_3$ . The gray trajectories indicate the background levels. The lifetime histograms of the QDs in a, b, and c are plotted in panels d, e, and f, respectively. In panel d, an expanded view of the data at short lifetimes is shown in the inset. Green bars in panels e and f indicate the occurrence of points with background intensity levels, for which the lifetime is assumed to be <0.25 ns.

single QDs on these substrates. The remaining trajectories for single QDs on ITO and In<sub>2</sub>O<sub>3</sub> are shown in Figures S3 and S4 (Supporting Information). Intensity trajectories, that is, count rates as a function time, were constructed by binning the detected photons within a 50 ms window. The delay time histograms constructed from photons within a 0.5 s bin time were fitted to a single exponential decay to obtain their lifetimes along the trajectories. A representative histogram and its single exponential fit are shown in Figure S5. Compared with QDs on glass and In<sub>2</sub>O<sub>3</sub>, single QDs on ITO show very different intensity and lifetime trajectories. First, the blinking activity of the QD on ITO is significantly suppressed. Fluorescence intermittence is a common property of single QDs.<sup>7–31</sup> For example, single QDs on glass (Figure 1b) and In<sub>2</sub>O<sub>3</sub> (Figure 1c and Figure S4) show strong fluorescence fluctuation between low intensity (background, off state) and a high intensity level (on state). However, for QDs on ITO (Figure 1a and Figure S3), the occurrence of blinking events is significantly reduced and the duration of the off state is shortened. For QDs on all substrates, the decrease of fluorescence intensity is accompanied by the reduction of lifetime, indicating a fluctuation in the nonradiative decay rate. Second, the lifetime of the QD on ITO is significantly shortened compared to those on glass and In<sub>2</sub>O<sub>3</sub>. The single QD on glass shown in Figure 1b has a broad on-state lifetime distribution centered at 23 ns. There are also events with intensity at the background level whose lifetimes cannot be accurately determined due to low count rates and were assumed to be <0.25 ns.

However, for the QD on ITO (Figure 1a,d), the lifetime distribution is shifted to much shorter lifetimes (with a peak at 3 ns) and becomes much narrower than those for QDs on glass and  $In_2O_3$ .

To compare the ensembles of single QDs on different substrates, we have constructed the total fluorescence lifetime (Figure 2a-c) and intensity (Figure 2d-f) distributions by adding up histograms of single QDs. The total lifetime distribution of QDs on glass shows an off-state peak (events with background fluorescence intensity level and estimated lifetimes <0.25 ns) and a broad on-state peak centered at  $\sim$ 22 ns. For QDs on In<sub>2</sub>O<sub>3</sub>, the on-state distribution is shifted to shorter lifetimes with a peak at  $\sim$ 14 ns and the amplitude of the off state is increased. For QDs on ITO, their on-state lifetime distribution is centered at  $\sim$  2.5 ns and becomes much narrower. Furthermore, the amplitude of off states becomes negligible. Because of the correlated change of fluorescence intensity and lifetime, a corresponding trend is also observed in the total fluorescence intensity distributions on these substrates. The total intensity histogram of QDs on glass shows broad distribution and two peaks for the on and off states. The on-state distribution is broad with a peak at a count rate of  $\sim$ 4 kHz (4000 counts per second), and the offstate peak is centered at  $\sim$ 400 Hz (background). For QDs on In<sub>2</sub>O<sub>3</sub>, the amplitude of the off-state peak becomes much larger and there is no apparent peak position in the on-state intensity distribution. The intensity histogram of QDs on ITO shifts to lower intensity levels with a peak centered at  $\sim$ 2 kHz. The distribution becomes much narrower, and there is negligible ampli-

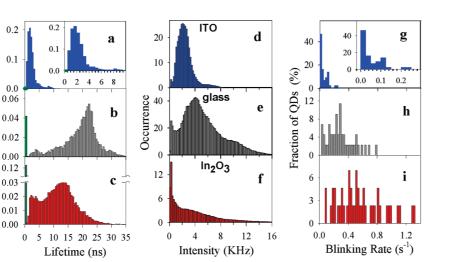


Figure 2. Comparison of lifetime and intensity distribution and fluctuation of single QDs on different substrates (47 on ITO, 45 on glass, and 50 on  $ln_2O_3$ ). Left panels: histograms of lifetime trajectories of all single QDs on (a) ITO, (b) glass, and (c)  $ln_2O_3$ . The green bars indicate the occurrence of low intensity points along the trajectories, for which the lifetimes have been assumed to be <0.25 ns. Middle panels: histograms of the fluorescence intensity of all studied singe QDs on (d) ITO, (e) glass, and (f)  $ln_2O_3$ . Right panels: histograms of blinking rate for single QDs on (g) ITO, (h) glass, and (i)  $ln_2O_3$ . In panels a and g, expanded views of the data are shown in the inset.

tude of state, indicating again the suppression of blinking activities.

Occurrence

To compare the blinking activities of single QDs on different substrates, we have calculated the blinking frequency (number of blinking events per second over 180 s long trajectories) for all measured single QDs. The threshold fluorescence intensity,  $l_{\rm Th}$ , separating the on and off states is defined as

$$I_{\rm Th} = I_{\rm av} + 3\sigma \tag{1}$$

where  $I_{av}$  is the average fluorescence intensity of the background and  $\sigma$  is its standard deviation. A blinking event is defined as a transition between the on and off states. The histograms of blinking frequency for single QDs on ITO, glass, and  $In_2O_3$  are compared in Figure 2g-i, respectively. For QDs on glass, the blinking frequency is broadly distributed with an average value of 0.30 Hz. On  $In_2O_3$ , the single QDs blink more rapidly with an average frequency of 0.56 Hz. However, for QDs on ITO, the average blinking frequency is dramatically reduced to 0.05 Hz and 95% of QDs have a blinking frequency of less than 0.14 Hz.

As another way to compare the blinking dynamics of QDs on different substrates, we have calculated the on- and off-state probability densities  $P_i(t)$  of single QDs according to the following definition:<sup>14</sup>

$$P_{i}(t) = \frac{N_{i}(t)}{N_{i,\text{total}}} \times \frac{1}{\Delta t_{i,\text{av}}} \quad (i = \text{ on or off})$$
(2)

where  $N_i(t)$  is the number of on or off events of duration time of t,  $N_{i,total}$  is the total number of on or off events, and  $\Delta t_{i,av}$  is the average of the time intervals to the preceding and following events. As shown in Figure 3a,b,  $P_{on}(t)$  and  $P_{off}(t)$  of single QDs on different substrates show a power law distribution at short time but deviate from this distribution at long time tails, similar to those reported in the literature.<sup>7,36,37,39–41</sup> These P(t) distributions can be fit by a truncated power law:<sup>18,20–22,39</sup>

$$P_i(t) = B_i t^{-m_i} \exp(-\Gamma_i t) \quad (i = \text{ on or off})$$
(3)

where *B* is the amplitude, *m* the power law exponent,

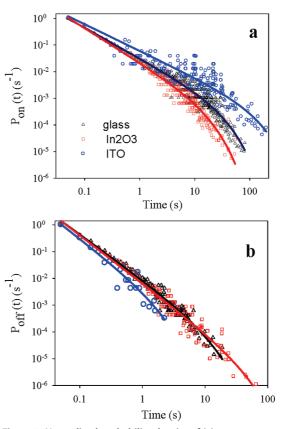


Figure 3. Normalized probability density of (a) on states ( $P_{on}(t)$ ) and (b) off states ( $P_{off}(t)$ ) for single QDs on ITO (blue circle), glass (black triangle), and  $In_2O_3$  (red square). The solid lines are best fits by eq 3.

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TABLE 1. Fitting Parameters of $P_{on}(t)$ and $P_{off}(t)$ for All					
Single QDs on Glass, In <sub>2</sub> O <sub>3</sub> , and ITO					

	mon	$1/\Gamma_{ m on}$ (s)	m <sub>off</sub>	1/ $\Gamma_{ m off}$ (s)
QDs on ITO	$0.90 \pm 0.05$	$84\pm18$	$1.82\pm0.3$	$1.7\pm0.7$
QDs on glass	$1.15\pm0.04$	$28\pm3$	$1.70\pm0.06$	$10\pm2$
QDs on $In_2O_3$	$1.30\pm0.05$	$15\pm1$	$1.80\pm0.07$	$39\pm14$

and  $\Gamma$  the saturation rate. The fitting parameters are listed in Table 1. Compared to glass, single QDs on ITO have a smaller  $\Gamma_{on}$  and larger  $\Gamma_{off}$ , suggesting increased probability densities of long on events and decreased probability densities of long off events. In fact, no off events with durations of longer than 3 s were observed for QDs on ITO. In contrast, single QDs on  $\ln_2O_3$  show smaller probability of long on events and a slightly larger probability of long (>10 s) off events than those on glass.

To ensure that these single QDs are representative of the ensembles, we have also measured ensembleaveraged fluorescence decays of QDs on glass,  $In_2O_3$ , and ITO. The ensemble measurements were conducted by using samples with a QD coverage level  $\sim 10^4$  times higher than those in single QD measurements. To avoid repetitive illumination of the same QDs, the samples were raster scanned at a speed of ~100 nm/s during the measurement. As shown in Figure 4, ensembleaveraged fluorescence decays of QDs on these substrates follow the same trend of decay rates as observed in single QD measurements. For a QD on glass and  $In_2O_3$ , the sum of single QD decays agrees well with the ensemble-averaged decays at long delay times (>4 ns) but shows a larger amplitude at early delay time, as shown in Figure S2 (Supporting Information). The difference is more pronounced on In<sub>2</sub>O<sub>3</sub> than glass. Similar differences between the sum of single QDs and ensemble-averaged measurement were observed in our previous comparison of QDs on TiO<sub>2</sub>.<sup>36</sup> Under single QD conditions, the repetitive illumination leads to the charging of QDs,<sup>6,12,16</sup> which results in a larger amplitude of fast decay components (due to Auger relaxation

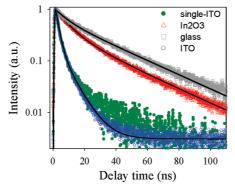


Figure 4. Ensemble-averaged fluorescence decays of QDs on ITO (blue open circles), glass (gray squares), and  $In_2O_3$  (red triangles). Solid lines are best biexponential fits. The fluorescence decay of the sum of all single QDs on ITO (green filled circles) is also shown.

in charge particles) than the ensemble decay kinetics. In contrast, For QDs on ITO, the sum of single QD decays agrees well with the ensemble-averaged decay, consistent with the much smaller off-state contribution in the single QD trajectories. These curves show a slight difference in long delay times. The reason for this difference is unclear. It may result from the lower signal-tonoise level of the single QD data. The comparison presented here confirms that the observed single QDs are representative of the whole ensembles on these substrates. The decay curves shown in Figure 4 can be well fit by biexponential functions. The time constants and amplitudes (in parentheses) are 7.5 ns (36%) and 31.5 ns (74%) on glass, 7.6 ns (61%) and 29.1 ns (39%) on In<sub>2</sub>O<sub>3</sub>, and 2.0 ns (85%) and 8.7 ns (15%) on ITO. The data on ITO show a long-lived ( $\gg$ 100 ns) component with 0.2% of the total amplitude, which has been attributed to the background signal. The amplitude weighted average time constants are 22.9 ns on glass, 16.0 ns on  $ln_2O_{3}$ , and 3.0 ns on ITO.

The CdSe/CdS<sub>3ML</sub>ZnCdS<sub>2ML</sub>ZnS<sub>2ML</sub> QDs used in this study have a first exciton peak at 605 nm, which is redshifted from the first exciton peak (574 nm) of the CdSe core. The estimated radius of the CdSe core is 1.8 nm.<sup>42</sup> Effective mass model calculations of CdSe/CdS core/ shell structures show that the lowest energy conduction band electron is delocalized in the core and shell, whereas the valence band hole remains localized in the core.<sup>43,44</sup> We attribute the red shift of the exciton peak position in our core/multishell structure to the lowering of the conduction band electron energy relative to the CdSe core. The estimated oxidation and reduction potentials of the 1S exciton in the core/multishell structure are -0.85 and +1.05 V (vs SCE), respectively.<sup>45-47</sup> The conduction and valence band potentials of In<sub>2</sub>O<sub>3</sub> at pH 7 are at -0.4 and 2.1 V (vs SCE), respectively.<sup>48</sup> As shown in Figure 5a, the offset of conduction band edge positions in In<sub>2</sub>O<sub>3</sub> and QD should enable photoinduced electron transfer from excited QDs to In<sub>2</sub>O<sub>3</sub>. ET from dye molecules (with excited-state potentials similar to the QDs) to In<sub>2</sub>O<sub>3</sub> nanocrystalline thin films has been observed previously.<sup>49,50</sup> ET from CdSe QDs to TiO<sub>2</sub>, whose conduction band edge is  $\sim$ 0.5 V higher than In<sub>2</sub>O<sub>3</sub>, has also been reported and verified in CdSe/TiO<sub>2</sub>-based solar cells.<sup>4,51–54</sup> For these reasons, we attribute the shorter lifetimes of QDs on In<sub>2</sub>O<sub>3</sub> to quenching by ET to In<sub>2</sub>O<sub>3</sub>. From the measured fluorescence lifetimes on glass and  $In_2O_3$ , an average ET rate from QDs to  $In_2O_3$ can be estimated to be  $1.9 \times 10^7$  s<sup>-1</sup>. This ET rate is similar to those for the same QDs on TiO<sub>2</sub>.<sup>36</sup> ET rate from CdSe core-only QDs (capped by mercaptopropionic acid) to TiO<sub>2</sub> nanoparticles was reported to be 6.3 imes $10^7$  and 6.7  $\times$  10<sup>8</sup> s<sup>-1</sup> for QDs with a first exciton peak at 605 and 570 nm, respectively.<sup>55</sup> In our core/multishell QDs, ZnS and CdZnS shells likely present a tunneling barrier for ET from the core because their conduction band edges are higher than CdS and CdSe.<sup>56,57</sup> In com-

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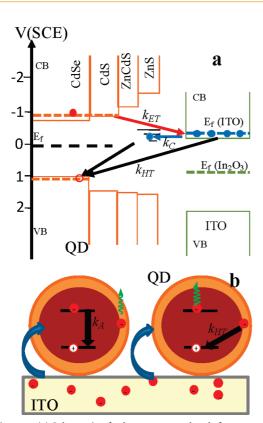


Figure 5. (a) Schematic of relevant energy levels for possible charge transfer pathways between QDs and ITO and  $In_2O_{3}$ ;  $k_{\rm ET}$  indicates the rate of electron transfer from QDs to ITO (or  $In_2O_3$ ). Values of  $k_{\rm HT}$  and  $k_c$  indicate the rate of hole transfer and charging of QDs on ITO, respectively. (b) Proposed exciton Auger recombination and hole transfer processes in negatively charged QDs on ITO.

parison to the core-only QDs,<sup>55</sup> the slower ET rate from our core/multishell QD may be attributed to the presence of the CdZnS and ZnS shells and different surface ligands. In addition, the comparison of blinking dynamics shows that single QDs on  $In_2O_3$  blink more frequently and have lower probability of long on states than those on glass. The effect of  $In_2O_3$  on the blinking dynamics of a QD is similar to those of TiO<sub>2</sub> and has been attributed to the presence of interfacial ET process.<sup>36</sup>

The conduction and valence band potentials for ITO are similar to those for  $In_2O_3$ .<sup>48</sup> Their Fermi levels are different, as shown in Figure 5a. The electron density for a 10% doped ITO has been estimated to be  $\sim 2.2 \times 10^{21}$  cm<sup>-3</sup>.<sup>58</sup> The Fermi level of the ITO film could then be calculated by<sup>59</sup>

$$E_{\rm f} = E_{\rm i} + kT \ln\left(\frac{N}{N_{\rm i}}\right) \tag{4}$$

where  $E_{\rm f}$  and  $E_{\rm i}$  and  $N(N_{\rm i})$  are the Fermi energy and conduction band electron density, respectively, of the doped (intrinsic) semiconductor, *k* is the Boltzmann constant, and *T* is the temperature.  $E_{\rm i}$  is assumed to be at the middle of the band gap for In<sub>2</sub>O<sub>3</sub> and is given by<sup>60</sup>

$$N_{\rm i}(T) = 2.5 \left(\frac{m_{\rm c} m_{\rm v}}{m_0^2}\right)^{3/4} \left(\frac{T}{300 \text{ K}}\right)^{3/2} \exp\left(-\frac{E_{\rm g}}{2kT}\right) 10^{19} \text{ cm}^{-3}$$
(5)

where  $E_g$  is the band gap energy of the semiconductor,  $m_c$  and  $m_v$  are the effective mass of the conduction band electron and valence band hole, respectively, and  $m_0$  is the mass of free electrons. Taking  $E_g = 2.5$  eV,<sup>48</sup>  $m_c = 0.3m_0$ ,  $m_v = 0.6m_0$  for  $\ln_2 O_{3r}^{61}$  we calculated  $N_i$  to be  $\sim 4.95 \times 10^{-3}$  cm<sup>-3</sup> at 298 K. Taking  $E_i = \sim 0.9$  eV (vs SCE),  $N = 2.2 \times 10^{21}$  cm<sup>-3</sup>, we estimate the Fermi level of ITO,  $E_f$ , to be  $\sim 100$  meV higher than its conduction band edge.

Because the Fermi level in ITO is close to its conduction band edge, only states near the band edge are filled. Most conduction band states are unoccupied and the density of electron accepting states for ET from QDs should not be significantly smaller than QD/ln<sub>2</sub>O<sub>3</sub>. For this reason, we assume that the ET rate from QDs to ITO is similar to that in QD/ln<sub>2</sub>O<sub>3</sub>. This assumption is validated by a previous study of ET from adsorbed molecules to ATO (Sb doped SnO<sub>2</sub>), in which it was shown that the ET rate was independent of the doping levels and was similar to that in undoped SnO<sub>2</sub>.<sup>62</sup> However, the observed average lifetime for QDs on ITO is significantly faster than that on In<sub>2</sub>O<sub>3</sub>, suggesting that the fast quenching of QD excitons cannot be attributed to ET from QDs to ITO.

The n-doped ITO provides two additional nonradiative quenching pathways that are not available on In<sub>2</sub>O<sub>3</sub> or glass. Because of the higher Fermi level in ITO than QDs, when they come in contact, electrons in ITO will be transferred to QDs until their Fermi levels are equilibrated. As a result, QDs will become negatively charged. A recent study of the fluorescence decays of CdSe/CdS core/shell QDs on ITO showed that their fluorescence lifetime decreased with increased negative bias, from which the lifetimes of negatively charged QDs were determined to be 700-1500 ps.<sup>38</sup> It was suggested that optical excitation of these negatively charged QDs formed negative trions (an exciton and an electron), whose lifetimes were shorter than single excitons in neutral QDs due to the presence of the Auger relaxation pathway involving the additional electron. Although the radiative rate of the trions is a factor two faster than single excitons, the main effect of the extra electron is the enhancement of its exciton Auger recombination rate. Under our experimental conditions, there is no applied external bias, and the initial Fermi level of ITO is below the conduction band edge of CdSe/ZnS QDs. The electrons in the negatively charged QDs likely fill in the trap states below the conduction band edge. We speculate that these trapped electrons can also provide fast nonradiative decay pathways for guenching the QD emission. As shown in Figure 5b, they can facilitate the nonradiative exciton recombination and/or

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combine with the valence band holes, both of which reduce the exciton lifetime. The observed average lifetime for QDs on ITO is about 3 ns, suggesting that these nonradiative decay processes involving trapped electrons are slightly slower than those reported for negative trions.<sup>38</sup>

Unlike on In<sub>2</sub>O<sub>3</sub> and glass, single QDs on ITO show narrow distributions of lifetimes and suppressed blinking activity with negligible contribution of off states. It is believed that, in the off state, QDs are charged and its excitons are nonemissive due to a fast Auger relaxation process involving the additional charge.<sup>7–31</sup> A direct measurement of QDs under optical illumination shows that QDs become positively charged.<sup>8</sup> A recent study of the lifetime and emission of intensity of negative trions shows that negatively charged QDs are optically bright and cannot account for the off state of single QDs.<sup>38</sup> These studies suggest that in off states QDs are positively charged. For the QDs on ITO, the holes are short-lived due to fast hole transfer processes to either the trapped electrons in the negatively charged QD or to ITO, inhibiting the formation of the off state. It should be noted that suppression of blinking has also been reported for QDs in reducing solution environments, which also provide electron sources to remove any long-lived holes in the QD.<sup>28,30</sup> Furthermore, in contact with the ITO, the charges of the QDs are likely maintained at a constant level because of Fermi level equilibration. For this reason, charging induced nonradiative decays should remain constant, which may be the reason for the small variations of intensity and lifetime throughout the trajectories and among different QDs on ITO.

Suppression of blinking and reduction of lifetime have also been observed for single QDs on metal substrates.<sup>26,34,63</sup> Shimizu *et al.* showed that, for CdSe/ZnS core/shell QDs on rough Au films, the reduction of lifetime is accompanied by an increase of fluorescence intensity, suggesting an enhancement of radiative decay and excitation rates, due to the enhanced local electric field.<sup>26</sup> They attribute the suppression of QD blinking to effective competition of the enhanced radiative process with exciton Auger recombination in charged QDs. This model is further supported by the observation that single QDs switch between two emission wavelengths, indicating the presence of two charge states. Similar blinking suppression and fluorescence enhancement of

single QDs on rough Au films were observed in a more recent study by Ito and co-workers, although a different model for the blinking suppression was proposed.<sup>63</sup> This study showed that on flat Au films single QDs also show suppressed blinking. In addition, both fluorescence lifetime and intensity are reduced. It was suggested that for single QDs on metal surfaces the suppression of blinking is due to a fast removal of charges from QDs by charge transfer to and from the metal substrate, and the reduction of lifetime is caused by energy transfer. In our model, we also assume a fast removal of holes in QDs. However, we suggest that the fast charge transfer between QDs and ITO should lead to the equilibration of their Fermi levels and the formation of negatively charged QDs. We attribute the reduction of lifetime and fluorescence intensity to the fast exciton Auger recombination<sup>38</sup> and hole transfer in negatively charged QDs.

## CONCLUSIONS

The exciton guenching dynamics of single CdSe/ CdS<sub>3ML</sub>ZnCdS<sub>2ML</sub>ZnS<sub>2ML</sub> core/multishell QDs adsorbed on glass, In<sub>2</sub>O<sub>3</sub>, and ITO have been compared. A good agreement of the average fluorescence lifetimes determined by single QDs and ensemble-averaged measurements on these substrates is observed, suggesting that the single QDs studied are representative of the ensembles. Single QDs on In<sub>2</sub>O<sub>3</sub> show shorter fluorescence lifetimes and higher blinking frequencies than those on glass. These differences can be attributed to the presence of interfacial ET from QDs to In<sub>2</sub>O<sub>3</sub> and are consistent with previous findings of single QDs on TiO<sub>2</sub>. In comparison to glass and In<sub>2</sub>O<sub>3</sub>, single QDs on ITO show suppressed blinking activity as well as reduced and more narrowly distributed fluorescence lifetimes and intensity. Due to the high doping level in ITO, the equilibration of the Fermi levels of QDs and ITO leads to the formation of negatively charged QDs. We speculate that the exciton Auger recombination and hole transfer processes in these negatively charged QDs shorten their fluorescence lifetime and suppress their blinking activities. This study shows that the blinking of single QDs can be effectively suppressed on the surface of ITO. This phenomenon may also be observable for other QDs and on different n-doped semiconductors.

### **METHODS**

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**Materials.** CdSe/CdS<sub>3ML</sub>ZnCdS<sub>2ML</sub>ZnS<sub>2ML</sub> core/multishell QDs (capped by octadecylamine ligand, first exciton absorption peak at 605 nm) were obtained from Ocean NanoTech, LLC, USA. Their absorption and emission spectra are shown in Figure S1a (Supporting Information). ITO-coated coverslips (15–30 ohms, 18 × 18 mm<sup>2</sup>, ~10% doping) were purchased from SPI Supplies.

anoTech, LLC, USA. 2-propanol, dried in air, and rapidly scanned over a flame for a few seconds to remove any adsorbed organic materials before versling (15–30 ohms

Heptane (99%) and 2-propanol (99.5%) were purchased from Sigma Aldrich and used without further purification. Glass coverslips ( $25 \times 25$ -1 mm) were purchased from Fisher Scientific. **Sample Preparation.** The ITO films were first washed by

use. The flame treatment process did not change the resistance of ITO. In<sub>2</sub>O<sub>3</sub> nanocrystalline thin films on glass coverslips were

prepared according to a reported procedure.<sup>49</sup> To prepare samples for single QD study, a QD heptane solution with a concentration of  $\sim\!10$  pM was spin-coated on ITO,  $In_2O_3$ , or glass coverslips. For ensemble-averaged measurement, the samples were prepared by spin-coating a QD solution with a concentration of  $\sim\!0.1~\mu M.$ 

Instruments. Both single QD and ensemble-averaged measurements were carried out with a home-built scanning confocal microscope. Femtosecond laser pulses (~100 fs) with a repetition rate of 80 MHz were generated with a mode-locked Ti:sapphire laser (Tsunami oscillator pumped by 10 W Millennia Pro, Spectra-Physics). The output centered at 1000 nm was passed through a pulse picker (Conoptics, USA) to reduce the repetition rate by a factor of 9 and then frequency doubled in a BBO crystal to generate 500 nm excitation pulses. The coverslips (glass, ITO, or In<sub>2</sub>O<sub>3</sub>) containing QDs were placed on a piezo scanner (Mad City Laboratories). The excitation beam (~150 nW) was focused through an objective  $(100 \times, NA 1.4, oil immersion, Olympus)$ down to a diffraction-limited spot on the sample. The resulting epifluorescence from the sample was detected by an avalanche photodiode (APD, Perkin-Elmer SPCM-AQR-14). The APD output was analyzed by a time-correlated single photon counting (TC-SPC) board (Becker&Hickel SPC 600). The instrument response function for the fluorescence lifetime measurement had a full width at half-maximum of  $\sim$  500 ps. In both single particle and ensemble-averaged measurements, QD fluorescence between 540 and 675 nm was selected by a band-pass filter for detection. A typical raster scanned fluorescence image of single QDs on ITO is shown in Figure S1b (Supporting Information).

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Supporting Information Available: Absorption and emission spectra, single QD image, comparison of single QD and ensemble-averaged fluorescence decays on ITO and glass, single QD fluorescence intensity and lifetime trajectories on ITO and In<sub>2</sub>O<sub>3</sub>, and a representative single QD fluorescence decay and single exponential fit. This material is available free of charge *via* the Internet at http://pubs.acs.org.

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